Intel - 5CSXFC6C6U23C8NES Datasheet





Welcome to E-XFL.COM

Embedded - System On Chip (SoC): The Heart of Modern Embedded Systems

Embedded - System On Chip (SoC) refers to an integrated circuit that consolidates all the essential components of a computer system into a single chip. This includes a microprocessor, memory, and other peripherals, all packed into one compact and efficient package. SoCs are designed to provide a complete computing solution, optimizing both space and power consumption, making them ideal for a wide range of embedded applications.

What are Embedded - System On Chip (SoC)?

System On Chip (SoC) integrates multiple functions of a computer or electronic system onto a single chip. Unlike traditional multi-chip solutions. SoCs combine a central

Details

Product Status	Obsolete
Architecture	MCU, FPGA
Core Processor	Dual ARM® Cortex®-A9 MPCore [™] with CoreSight [™]
Flash Size	·
RAM Size	64KB
Peripherals	DMA, POR, WDT
Connectivity	CANbus, EBI/EMI, Ethernet, I ² C, MMC/SD/SDIO, SPI, UART/USART, USB OTG
Speed	600MHz
Primary Attributes	FPGA - 110K Logic Elements
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-FBGA
Supplier Device Package	672-UBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/intel/5csxfc6c6u23c8nes

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Maximum Allowed Overshoot and Undershoot Voltage

During transitions, input signals may overshoot to the voltage listed in the following table and undershoot to -2.0 V for input currents less than 100 mA and periods shorter than 20 ns.

The maximum allowed overshoot duration is specified as a percentage of high time over the lifetime of the device. A DC signal is equivalent to 100% duty cycle.

For example, a signal that overshoots to 4.00 V can only be at 4.00 V for \sim 15% over the lifetime of the device; for a device lifetime of 10 years, this amounts to 1.5 years.

Table 3. Maximum Allowed Overshoot During Transitions for Cyclone V Devices

Symbol	Description	Condition (V)	Overshoot Duration as % of High Time	Unit
Vi (AC)	AC input voltage	3.8	100	%
		3.85	68	%
		3.9	45	%
		3.95	28	%
		4	15	%
		4.05	13	%
		4.1	11	%
		4.15	9	%
		4.2	8	%
		4.25	7	%
		4.3	5.4	%
		4.35	3.2	%
		4.4	1.9	%
		4.45	1.1	%
				continued

This table lists the maximum allowed input overshoot voltage and the duration of the overshoot voltage as a percentage of device lifetime.

CV-51002 | 2018.05.07



Symbol	Description	Condition	Minimum ⁽²⁾	Typical	Maximum ⁽²⁾	Unit
V _{CCPGM}	Configuration pins power supply	3.3 V	3.135	3.3	3.465	V
		3.0 V	2.85	3.0	3.15	V
		2.5 V	2.375	2.5	2.625	V
		1.8 V	1.71	1.8	1.89	V
V _{CCA_FPLL} ⁽⁵⁾	PLL analog voltage regulator power supply	-	2.375	2.5	2.625	V
V _{CCBAT} ⁽⁶⁾	Battery back-up power supply (For design security volatile key register)	_	1.2	_	3.0	V
VI	DC input voltage	-	-0.5	-	3.6	V
Vo	Output voltage	_	0	-	V _{CCIO}	V
Тյ	Operating junction temperature	Commercial	0	-	85	°C
		Industrial	-40	-	100	°C
		Automotive	-40	-	125	°C
t _{RAMP} ⁽⁷⁾	Power supply ramp time	Standard POR	200µs	—	100ms	—
		Fast POR	200µs	-	4ms	_

⁽²⁾ The power supply value describes the budget for the DC (static) power supply tolerance and does not include the dynamic tolerance requirements. Refer to the PDN tool for the additional budget for the dynamic tolerance requirements.

⁽⁵⁾ PLL digital voltage is regulated from V_{CCA} FPLL.

⁽⁶⁾ If you do not use the design security feature in Cyclone V devices, connect V_{CCBAT} to a 1.5-V, 2.5-V, or 3.0-V power supply. Cyclone V power-on reset (POR) circuitry monitors V_{CCBAT}. Cyclone V devices do not exit POR if V_{CCBAT} is not powered up.

⁽⁷⁾ This is also applicable to HPS power supply. For HPS power supply, refer to t_{RAMP} specifications for standard POR when HPS PORSEL = 0 and t_{RAMP} specifications for fast POR when HPS PORSEL = 1.



Table 22.Transceiver Clocks Specifications for Cyclone V GX, GT, SX, and ST Devices

Symbol/Description	Condition	Transceiv	Transceiver Speed Grade 5 ⁽³⁰⁾			iver Speed	Grade 6	Transce	Unit		
		Min	Тур	Мах	Min	Тур	Max	Min	Тур	Мах	
fixedclk clock frequency	PCIe Receiver Detect	-	125	_	—	125	-	_	125	-	MHz
Transceiver Reconfiguration Controller IP (mgmt_clk_clk) clock frequency	_	75	_	100/125 ⁽³ 7)	75	_	100/125 ⁽ 37)	75	_	100/125 ⁽³ 7)	MHz

Table 23. Receiver Specifications for Cyclone V GX, GT, SX, and ST Devices

Symbol/Description	Condition	Transceiv	er Speed G	rade 5 ⁽³⁰⁾	Transce	iver Speed	Grade 6	Transce	iver Speed	Grade 7	Unit
		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	
Supported I/O standards	1.5 V PCML, 2.5 V PCML, LVPECL, and LVDS										
Data rate ⁽³⁸⁾	_	614	_	5000/614 4 ⁽³⁵⁾	614	-	3125	614	-	2500	Mbps
Absolute V_{MAX} for a receiver pin ⁽³⁹⁾	_	-	_	1.2	_	-	1.2	_	-	1.2	V
Absolute V_{MIN} for a receiver pin	_	-0.4	-	-	-0.4	-	-	-0.4	-	-	V
Maximum peak-to-peak differential input voltage $V_{\rm ID}$ (diff p-p) before device configuration	_	_	_	1.6	_	_	1.6	_	_	1.6	V
Maximum peak-to-peak differential input voltage $V_{\rm ID}$ (diff p-p) after device configuration	_	_	_	2.2	_	_	2.2	_	_	2.2	V
									•	co	ntinued

⁽³⁷⁾ The maximum supported clock frequency is 100 MHz if the PCIe hard IP block is enabled or 125 MHz if the PCIe hard IP block is not enabled.

⁽³⁸⁾ To support data rates lower than the minimum specification through oversampling, use the CDR in LTR mode only.

⁽³⁹⁾ The device cannot tolerate prolonged operation at this absolute maximum.

CV-51002 | 2018.05.07



Symbol/Description	Condition	Transceiv	er Speed G	rade 5 ⁽³⁰⁾	Transce	iver Speed	Grade 6	Transce	Unit		
		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	
Programmable ppm detector ⁽⁴⁶⁾	_	±62.5, 100, 125, 200, 250, 300, 500, and 1000								ppm	
Run length	-	-	-	200	-	-	200	-	-	200	UI
Programmable equalization AC and DC gain	AC gain setting = 0 to 3 $^{(47)}$ DC gain setting = 0 to 1	Refer to CTLE Response at Data Rates > 3.25 Gbps across Supported AC Gain and DC Gain for Cyclone V GX , GT , SX , and ST Devices and CTLE Response at Data Rates \leq 3.25 Gbps across Supported AC Gain and DC Gain for Cyclone V GX , GT , SX , and ST Devices diagrams.							dB		

Table 24. Transmitter Specifications for Cyclone V GX, GT, SX, and ST Devices

Symbol/Description	Condition	Transceiv	er Speed G	rade 5 ⁽³⁰⁾	Transce	iver Speed	Grade 6	Transce	iver Speed	Grade 7	Unit
		Min	Тур	Мах	Min	Тур	Max	Min	Тур	Max]
Supported I/O standards		1.5 V PCML									
Data rate	_	$- \qquad 614 \qquad - \qquad 5000/614 \\ 4^{(35)} \qquad 614 \qquad - \qquad 3125 \qquad 614 \qquad - \qquad 2500$								Mbps	
V _{OCM} (AC coupled)	_	-	650	-	—	650	-	-	650	-	mV
Differential on-chip	85-Ω setting	-	85	-	_	85	-	-	85	-	Ω
termination resistors	100-Ω setting	-	100	-	_	100	-	-	100	-	Ω
	120-Ω setting	-	120	-	_	120	-	-	120	-	Ω
	150-Ω setting	_	150	-	_	150	-	_	150	-	Ω
										со	ntinued

 $^{^{(45)}}$ t_{LTR_LTD_manual} is the time the receiver CDR must be kept in lock to reference (LTR) mode after the rx_is_lockedtoref signal goes high when the CDR is functioning in the manual mode.

⁽⁴⁶⁾ The rate matcher supports only up to ± 300 parts per million (ppm).

⁽⁴⁷⁾ The Intel Quartus Prime software allows AC gain setting = 3 for design with data rate between 614 Mbps and 1.25 Gbps only.



Typical TX V_{OD} Setting for Cyclone V Transceiver Channels with termination of 100 Ω

Table 27. Typical TX V_{OD} Setting for Cyclone V Transceiver Channels with termination of 100 Ω

Symbol	V _{OD} Setting ⁽⁴⁸⁾	V _{OD} Value (mV)	V _{OD} Setting ⁽⁴⁸⁾	V _{OD} Value (mV)
V _{OD} differential peak-to-peak typical	6 ⁽⁴⁹⁾	120	34	680
	7 ⁽⁴⁹⁾	140	35	700
	8 ⁽⁴⁹⁾	160	36	720
	9	180	37	740
	10	200	38	760
	11	220	39	780
	12	240	40	800
	13	260	41	820
	14	280	42	840
	15	300	43	860
	16	320	44	880
	17	340	45	900
	18	360	46	920
	19	380	47	940
	20	400	48	960
	21	420	49	980
	22	440	50	1000
	23	460	51	1020
	24	480	52	1040
		•		continued

⁽⁴⁸⁾ Convert these values to their binary equivalent form if you are using the dynamic reconfiguration mode for PMA analog controls.

⁽⁴⁹⁾ Only valid for data rates \leq 5 Gbps.

CV-51002 | 2018.05.07



Protocol	Sub-protocol	Data Rate (Mbps)
	CPRI E12LV	1,228.8
	CPRI E12HV	1,228.8
	CPRI E12LVII	1,228.8
	CPRI E24LV	2,457.6
	CPRI E24LVII	2,457.6
	CPRI E30LV	3,072
	CPRI E30LVII	3,072
	CPRI E48LVII ⁽⁵¹⁾	4,915.2
	CPRI E60LVII ⁽⁵¹⁾	6,144
Gbps Ethernet (GbE)	GbE 1250	1,250
OBSAI	OBSAI 768	768
	OBSAI 1536	1,536
	OBSAI 3072	3,072
Serial digital interface (SDI)	SDI 270 SD	270
	SDI 1485 HD	1,485
	SDI 2970 3G	2,970
VbyOne	VbyOne 3750	3,750
HiGig+	HIGIG 3750	3,750

Related Information

• PCIe Supported Configurations and Placement Guidelines

Provides more information about the maximum full duplex channels recommended in Cyclone V GT and ST devices which require full compliance to the PCIe Gen2 transmit jitter specification.

⁽⁵¹⁾ For CPRI E48LVII and E60LVII, Intel recommends increasing the V_{CCE_GXBL} and V_{CCL_GXBL} typical value from 1.1 V to 1.2 V for full compliance to CPRI transmit jitter specification at 4.9152 Gbps (Cyclone V GT and ST devices) and 6.144 Gbps (Cyclone V GT and ST devices only). For more information about the maximum full duplex channels recommended in Cyclone V GT and ST devices for CPRI 6.144 Gbps, refer to the *Transceiver Protocol Configurations in Cyclone V Devices* chapter.

CV-51002 | 2018.05.07



Symbol	Parameter	Condition	Min	Тур	Мах	Unit
		-C8, -A7 speed grades	600	-	1300	MHz
teinduty	Input clock or external feedback clock input duty cycle	_	40	_	60	%
fout	Output frequency for internal global or regional clock	–C6, –C7, –I7 speed grades	_	_	550 ⁽⁵⁴⁾	MHz
		–C8, –A7 speed grades	_	_	460 ⁽⁵⁴⁾	MHz
f _{OUT_EXT}	Output frequency for external clock output	–C6, –C7, –I7 speed grades	_	_	667 ⁽⁵⁴⁾	MHz
		–C8, –A7 speed grades	-	-	533 ⁽⁵⁴⁾	MHz
toutduty	Duty cycle for external clock output (when set to 50%)	_	45	50	55	%
t _{FCOMP}	External feedback clock compensation time	-	-	-	10	ns
t _{DYCONFIGCLK}	Dynamic configuration clock for mgmt_clk and scanclk	_	_	_	100	MHz
t _{LOCK}	Time required to lock from end-of-device configuration or deassertion of areset	_	_	_	1	ms
t _{DLOCK}	Time required to lock dynamically (after switchover or reconfiguring any non-post- scale counters/delays)	_	_	_	1	ms
f _{CLBW}	PLL closed-loop bandwidth	Low	-	0.3	-	MHz
		Medium	-	1.5	-	MHz
		High ⁽⁵⁵⁾	-	4	-	MHz
t _{PLL_PSERR}	Accuracy of PLL phase shift	-	-	-	±50	ps
		• •				continued

⁽⁵³⁾ The VCO frequency reported by the Intel Quartus Prime software takes into consideration the VCO post-scale counter κ value. Therefore, if the counter κ has a value of 2, the frequency reported can be lower than the f_{VCO} specification.

 $^{^{(54)}}$ This specification is limited by the lower of the two: I/O f_{MAX} or F_{OUT} of the PLL.

⁽⁵⁵⁾ High bandwidth PLL settings are not supported in external feedback mode.



High-Speed I/O Specifications

Table 34. High-Speed I/O Specifications for Cyclone V Devices

When J = 1 or 2, bypass the serializer/deserializer (SERDES) block.

For LVDS applications, you must use the PLLs in integer PLL mode. This is achieved by using the LVDS clock network.

The Cyclone V devices support the following output standards using true LVDS output buffer types on all I/O banks.

- True RSDS output standard with data rates of up to 360 Mbps
- True mini-LVDS output standard with data rates of up to 400 Mbps

	Symbol	Condition		-C6			-C7, -I7			-C8, -A7		Unit
			Min	Тур	Max	Min	Тур	Max	Min	Тур	Мах	
f _{HSCLK_in} (input clo Standards	ck frequency) True Differential I/O	Clock boost factor W = 1 to $40^{(63)}$	5	_	437.5	5	_	420	5		320	MHz
f _{HSCLK_in} (input clo Standards	ck frequency) Single-Ended I/O	Clock boost factor W = 1 to $40^{(63)}$	5	_	320	5	_	320	5	_	275	MHz
f _{HSCLK_OUT} (output	clock frequency)	_	5	_	420	5	-	370	5	_	320	MHz
Transmitter	True Differential I/O Standards - f _{HSDR} (data rate)	SERDES factor J =4 to $10^{(64)}$	(65)	_	840	(65)	_	740	(65)	_	640	Mbps
											cont	inued

⁽⁶⁵⁾ The minimum specification depends on the clock source (for example, the PLL and clock pin) and the clock routing resource (global, regional, or local) that you use. The I/O differential buffer and input register do not have a minimum toggle rate.

⁽⁶³⁾ Clock boost factor (W) is the ratio between the input data rate and the input clock rate.

⁽⁶⁴⁾ The F_{max} specification is based on the fast clock used for serial data. The interface F_{max} is also dependent on the parallel clock domain which is design dependent and requires timing analysis.



	Symbol	Condition		-C6			-C7, -I7			-C8, -A7		Unit
			Min	Тур	Max	Min	Тур	Мах	Min	Тур	Мах	
		Emulated Differential I/O Standards										
	t_{RISE} and t_{FALL}	True Differential I/O Standards	_	_	200	-	-	200	_	_	200	ps
		Emulated Differential I/O Standards with Three External Output Resistor Networks	-	_	250	_	_	250	_	_	300	ps
		Emulated Differential I/O Standards with One External Output Resistor Network	_	_	300	_	_	300	_	_	300	ps
	TCCS	True Differential I/O Standards	-	-	200	-	-	250	-	_	250	ps
		Emulated Differential I/O Standards with Three External Output Resistor Networks	-	_	300	-	_	300	_	_	300	ps
		Emulated Differential I/O Standards with One External Output Resistor Network	-	_	300	-	_	300	_	_	300	ps
Receiver	f _{HSDR} (data rate)	SERDES factor J =4 to $10^{(64)}$	(65)	-	875 ⁽⁶⁷⁾	(65)	-	840 ⁽⁶⁷⁾	(65)	_	640 ⁽⁶⁷⁾	Mbps
		SERDES factor J = 1 to 2, uses DDR registers	(65)	-	(66)	(65)	-	(66)	(65)	-	(66)	Mbps
Sampling Window		_	_	_	350	_	_	350	_	_	350	ps



SD/MMC Timing Characteristics

Table 46. Secure Digital (SD)/MultiMediaCard (MMC) Timing Requirements for Cyclone V Devices

After power up or cold reset, the Boot ROM uses drvsel = 3 and smplsel = 0 to execute the code. At the same time, the SD/MMC controller enters the Identification Phase followed by the Data Phase. During this time, the value of interface output clock SDMMC_CLK_OUT changes from a maximum of 400 kHz (Identification Phase) up to a maximum of 12.5 MHz (Data Phase), depending on the internal reference clock SDMMC_CLK and the CSEL setting. The value of SDMMC_CLK is based on the external oscillator frequency and has a maximum value of 50 MHz.

After the Boot ROM code exits and control is passed to the preloader, software can adjust the value of drvsel and smplsel via the system manager. drvsel can be set from 1 to 7 and smplsel can be set from 0 to 7. While the preloader is executing, the values for SDMMC_CLK and SDMMC_CLK_OUT increase to a maximum of 200 MHz and 50 MHz respectively.

Symbol	Description	Min	Мах	Unit
T _{sdmmc_clk} (internal reference clock)	SDMMC_CLK clock period (Identification mode)	20	_	ns
	SDMMC_CLK clock period (Default speed mode)	5	_	ns
	SDMMC_CLK clock period (High speed mode)	5	_	ns
T _{sdmmc_clk_out} (interface output clock)	SDMMC_CLK_OUT clock period (Identification mode)	2500	_	ns
	SDMMC_CLK_OUT clock period (Default speed mode)	40	_	ns
	SDMMC_CLK_OUT clock period (High speed mode)	20	_	ns
T _{dutycycle}	SDMMC_CLK_OUT duty cycle	45	55	%
T _d	SDMMC_CMD/SDMMC_D output delay	(T _{sdmmc_clk} × drvsel)/2 - 1.23 (70)	(T _{sdmmc_clk} × drvsel)/2 + 1.69 ⁽⁷⁰⁾	ns
T _{su}	Input setup time	$1.05 - (T_{sdmmc_clk} \times smplsel)/2$	_	ns
T _h	Input hold time	$(T_{sdmmc_{clk}} \times smplsel)/2$ (71)	-	ns

⁽⁷⁰⁾ drvsel is the drive clock phase shift select value.

⁽⁷¹⁾ smplsel is the sample clock phase shift select value.

Figure 13. MDIO Timing Diagram



I²C Timing Characteristics

Table 51. I	² C Timing	Requirements	for Cyclone \	/ Devices
-------------	-----------------------	---------------------	---------------	-----------

Symbol	Description	Standar	d Mode	Fast	Mode	Unit
		Min	Max	Min	Max	
T _{clk}	Serial clock (SCL) clock period	10	_	2.5	-	μs
T _{clkhigh}	SCL high time	4.7	-	0.6	-	μs
T _{clklow}	SCL low time	4	-	1.3	-	μs
Ts	Setup time for serial data line (SDA) data to SCL	0.25	-	0.1	-	μs
T _h	Hold time for SCL to SDA data	0	3.45	0	0.9	μs
T _d	SCL to SDA output data delay	-	0.2	_	0.2	μs
T _{su_start}	Setup time for a repeated start condition	4.7	—	0.6	—	μs
T _{hd_start}	Hold time for a repeated start condition	4	_	0.6	—	μs
T _{su_stop}	Setup time for a stop condition	4	_	0.6	_	μs



Figure 16. NAND Address Latch Timing Diagram





Figure 17. NAND Data Write Timing Diagram





Symbol	Description	Min	Max	Unit
t _{JPCO}	JTAG port clock to output	—	11 ⁽⁷⁶⁾	ns
t _{JPZX}	JTAG port high impedance to valid output	—	14 ⁽⁷⁶⁾	ns
t _{JPXZ}	JTAG port valid output to high impedance	_	14 ⁽⁷⁶⁾	ns

FPP Configuration Timing

DCLK-to-DATA[] Ratio (r) for FPP Configuration

Fast passive parallel (FPP) configuration requires a different DCLK-to-DATA[] ratio when you turn on encryption or the compression feature.

Depending on the DCLK-to-DATA[] ratio, the host must send a DCLK frequency that is r times the DATA[] rate in byte per second (Bps) or word per second (Wps). For example, in FPP ×16 where the r is 2, the DCLK frequency must be 2 times the DATA[] rate in Wps.

Cyclone V devices use additional clock cycles to decrypt and decompress the configuration data. If the DCLK-to-DATA[] ratio is greater than 1, at the end of configuration, you can only stop the DCLK (DCLK-to-DATA[] ratio – 1) clock cycles after the last data is latched into the Cyclone V device.

Table 57. DCLK-to-DATA[] Ratio for Cyclone V Devices

Configuration Scheme	Encryption	Compression	DCLK-to-DATA[] Ratio (r)
FPP (8-bit wide)	Off	Off	1
	On	Off	1
	Off	On	2
	On	On	2
FPP (16-bit wide)	Off	Off	1
		•	continued

⁽⁷⁶⁾ A 1-ns adder is required for each VCCIO voltage step down from 3.0 V. For example, tJPCO= 13 ns if VCCIO of the TDO I/O bank = 2.5 V, or 14 ns if it equals 1.8 V.



Symbol	Parameter	Minimum	Maximum	Unit
t _{CL}	DCLK low time	$0.45 \times 1/f_{MAX}$	_	s
t _{CLK}	DCLK period	1/f _{MAX}	_	S
f _{MAX}	DCLK frequency (FPP ×8/ ×16)	_	125	MHz
t _{CD2UM}	CONF_DONE high to user mode ⁽⁸⁰⁾	175	437	μs
t _{CD2CU}	CONF_DONE high to CLKUSR enabled	4× maximum DCLK period	-	—
t _{CD2UMC}	CONF_DONE high to user mode with CLKUSR option on	t _{CD2CU} + (T _{init} × CLKUSR period)	_	_
T _{init}	Number of clock cycles required for device initialization	8,576	—	Cycles

Related Information

- FPP Configuration Timing Provides the FPP configuration timing waveforms.
- DCLK-to-DATA[] Ratio (r) for FPP Configuration on page 69

FPP Configuration Timing when DCLK-to-DATA[] >1

Table 59. FPP Timing Parameters When DCLK-to-DATA[] Ratio is >1 for Cyclone V Devices

Use these timing parameters when you use the decompression and design security features.

Symbol	Parameter	Minimum	Maximum	Unit
t _{CF2CD}	nCONFIG low to CONF_DONE low	_	600	ns
t _{CF2ST0}	nCONFIG low to nSTATUS low	_	600	ns
t _{CFG}	nCONFIG low pulse width	2	—	μs
t _{STATUS}	nSTATUS low pulse width	268	1506 ⁽⁸¹⁾	μs
t _{CF2ST1}	nCONFIG high to nSTATUS high	-	1506 ⁽⁸²⁾	μs
	continued			

⁽⁸⁰⁾ The minimum and maximum numbers apply only if you chose the internal oscillator as the clock source for initializing the device.

⁽⁸¹⁾ This value can be obtained if you do not delay configuration by extending the nCONFIG or nSTATUS low pulse width.



Active Serial (AS) Configuration Timing

Table 60.AS Timing Parameters for AS ×1 and ×4 Configurations in Cyclone V Devices

The minimum and maximum numbers apply to both the internal oscillator and CLKUSR when either one is used as the clock source for device configuration.

The t_{CF2CD} , t_{CF2ST0} , t_{CFG} , t_{STATUS} , and t_{CF2ST1} timing parameters are identical to the timing parameters for passive serial (PS) mode listed in *PS Timing Parameters for Cyclone V Devices* table. You can obtain the t_{CF2ST1} value if you do not delay configuration by externally holding nSTATUS low.

Symbol	Parameter	Minimum	Maximum	Unit
t _{co}	DCLK falling edge to the AS_DATA0/ASDO output	_	2	ns
t _{SU}	Data setup time before the falling edge on DCLK	1.5	-	ns
t _{DH} ⁽⁸⁶⁾	Data hold time after the falling edge on DCLK	2.5 ⁽⁸⁷⁾ /2.9 ⁽⁸⁸⁾	-	ns
t _{CD2UM}	CONF_DONE high to user mode	175	437	μs
t _{CD2CU}	CONF_DONE high to CLKUSR enabled	4 × maximum DCLK period	-	_
t _{CD2UMC}	CONF_DONE high to user mode with CLKUSR option on	t _{CD2CU} + (T _{init} × CLKUSR period)	-	-
T _{init}	Number of clock cycles required for device initialization	8,576	-	Cycles

Related Information

- Passive Serial (PS) Configuration Timing on page 74
- AS Configuration Timing Provides the AS configuration timing waveform.
- AN822: Intel FPGA Configuration Device Migration Guideline

 $^(^{86})$ Note: To evaluate the data setup (t_{SU}) and data hold time (t_{DH}) slack on your board in order to ensure you are meeting the t_{SU} and t_{DH} requirement, you are recommended to follow the guideline in the "Evaluating Data Setup and Hold Timing Slack" chapter in AN822: Intel FPGA Configuration Device Migration Guideline.

⁽⁸⁷⁾ Specification for -6 speed grade

⁽⁸⁸⁾ Specification for -7 and -8 speed grade



DCLK Frequency Specification in the AS Configuration Scheme

Table 61. DCLK Frequency Specification in the AS Configuration Scheme

This table lists the internal clock frequency specification for the AS configuration scheme. The DCLK frequency specification applies when you use the internal oscillator as the configuration clock source. The AS multi-device configuration scheme does not support DCLK frequency of 100 MHz.

Parameter	Minimum	Typical	Maximum	Unit
DCLK frequency in AS configuration scheme	5.3	7.9	12.5	MHz
	10.6	15.7	25.0	MHz
	21.3	31.4	50.0	MHz
	42.6	62.9	100.0	MHz

Passive Serial (PS) Configuration Timing

Table 62. PS Timing Parameters for Cyclone V Devices

Symbol	Parameter	Minimum	Maximum	Unit	
t _{CF2CD}	nCONFIG low to CONF_DONE low	_	600	ns	
t _{CF2ST0}	nCONFIG low to nSTATUS low	_	600	ns	
t _{CFG}	nCONFIG low pulse width	2	_	μs	
t _{STATUS}	nSTATUS low pulse width	268	1506 ⁽⁸⁹⁾	μs	
t _{CF2ST1}	nCONFIG high to nSTATUS high	-	1506 ⁽⁹⁰⁾	μs	
t _{CF2CK} ⁽⁹¹⁾	nCONFIG high to first rising edge on DCLK	1506	-	μs	
t _{ST2CK} ⁽⁹¹⁾	nSTATUS high to first rising edge of DCLK	2	-	μs	
t _{DSU}	DATA[] setup time before rising edge on DCLK	5.5	-	ns	
	continued				

⁽⁸⁹⁾ You can obtain this value if you do not delay configuration by extending the nCONFIG or nSTATUS low pulse width.

⁽⁹⁰⁾ You can obtain this value if you do not delay configuration by externally holding nSTATUS low.

⁽⁹¹⁾ If nSTATUS is monitored, follow the t_{ST2CK} specification. If nSTATUS is not monitored, follow the t_{CF2CK} specification.



Programmable Output Buffer Delay

Table 69. Programmable Output Buffer Delay for Cyclone V Devices

This table lists the delay chain settings that control the rising and falling edge delays of the output buffer.

You can set the programmable output buffer delay in the Intel Quartus Prime software by setting the **Output Buffer Delay Control** assignment to either positive, negative, or both edges, with the specific values stated here (in ps) for the **Output Buffer Delay** assignment.

Symbol	Parameter	Typical	Unit
D _{OUTBUF}	Rising and/or falling edge delay	0 (default)	ps
		50	ps
		100	ps
		150	ps

Glossary

Table 70.Glossary

Term	Definition
Differential I/O standards	Receiver Input Waveforms
	continued



Date	Version	Changes
June 2013	3.4	 Updated Table 20, Table 27, and Table 34. Updated "UART Interface" and "CAN Interface" sections. Removed the following tables: Table 45: UART Baud Rate for Cyclone V Devices Table 47: CAN Pulse Width for Cyclone V Devices
May 2013	3.3	 Added Table 33. Updated Figure 5, Figure 6, Figure 17, Figure 19, and Figure 20. Updated Table 1, Table 4, Table 5, Table 10, Table 13, Table 19, Table 20, Table 26, Table 32, Table 35, Table 36, Table 43, Table 53, Table 54, Table 57, and Table 61.
March 2013	3.2	 Added HPS reset information in the "HPS Specifications" section. Added Table 57. Updated Table 1, Table 2, Table 17, Table 20, Table 52, and Table 56. Updated Figure 18.
January 2013	3.1	Updated Table 4, Table 20, and Table 56.
November 2012	3.0	 Updated Table 1, Table 4, Table 5, Table 9, Table 14, Table 16, Table 17, Table 19, Table 20, Table 25, Table 28, Table 52, Table 55, Table 56, and Table 59. Removed table: Transceiver Block Jitter Specifications for Cyclone V GX Devices. Added HPS information: Added "HPS Specifications" section. Added Table 33, Table 34, Table 35, Table 36, Table 37, Table 38, Table 39, Table 40, Table 41, Table 42, Table 43, Table 44, Table 45, and Table 46. Added Figure 4, Figure 5, Figure 6, Figure 7, Figure 8, Figure 9, Figure 10, Figure 11, Figure 12, Figure 13, Figure 14, Figure 15, and Figure 16. Updated Table 3.
June 2012	2.0	 Updated for the Quartus Prime software v12.0 release: Restructured document. Removed "Power Consumption" section. Updated Table 1, Table 3, Table 19, Table 20, Table 25, Table 27, Table 28, Table 30, Table 31, Table 34, Table 36, Table 37, Table 38, Table 39, Table 41, Table 43, and Table 46. Added Table 22, Table 23, and Table 29. Added Figure 1 and Figure 2. Added "Initialization" and "Configuration Files" sections.

CV-51002 | 2018.05.07



Date	Version	Changes
February 2012	1.2	 Added automotive speed grade information. Added Figure 2-1. Updated Table 2-3, Table 2-8, Table 2-9, Table 2-19, Table 2-20, Table 2-21, Table 2-22, Table 2-23, Table 2-24, Table 2-25, Table 2-26, Table 2-27, Table 2-28, Table 2-30, Table 2-35, and Table 2-43. Minor text edits.
November 2011	1.1	 Added Table 2–5. Updated Table 2–3, Table 2–4, Table 2–11, Table 2–13, Table 2–20, and Table 2–21.
October 2011	1.0	Initial release.